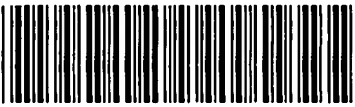


<b>Search Notes</b>  	<b>Application/Control No.</b>  10631947	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  O'Connor, Brian T	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
370	286, 356, 401	03/30/2007	Brian T. O'Connor

SEARCH NOTES		
Search Notes	Date	Examiner
US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	03/30/2007	Brian T. O'Connor
US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	10/10/2007	Brian T. O'Connor

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner